

## 100V N-Channel Enhancement Mode MOSFET

### Description

The AP5N10BI uses advanced **APM-SGTII** technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### General Features

$V_{DS} = 100V$   $I_D = 5.0A$

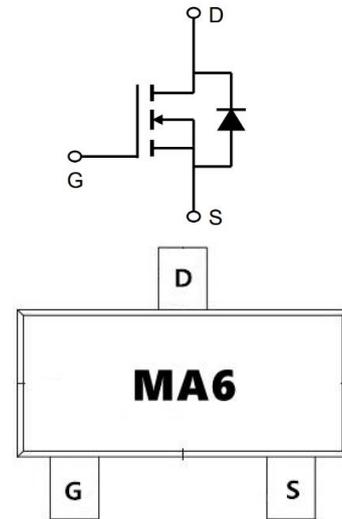
$R_{DS(ON)} < 130m\Omega$  @  $V_{GS}=10V$  (Type: **100mΩ**)

### Application

LED

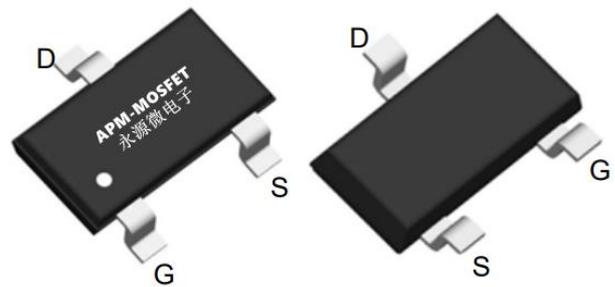
Load switch

Uninterruptible power supply



Top View

Bottom View



### Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP5N10BI	SOT23L	MA6	3000

### Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	100	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D@T_A=25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10V^1$	5	A
$I_D@T_A=70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10V^1$	3.2	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	16	A
$P_D@T_A=25^\circ\text{C}$	Total Power Dissipation <sup>3</sup>	3.1	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance Junction-ambient(steady state) <sup>1</sup>	125	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance Junction-ambient( $t < 10s$ ) <sup>1</sup>	40	$^\circ\text{C/W}$

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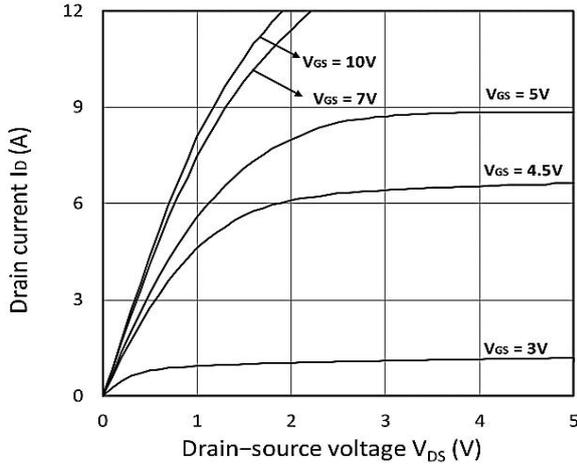
### Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
V(BR)DSS	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	100	-	-	V
IGSS	Gate-body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	$\pm 100$	nA
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 100V, V_{GS} = 0V$	-	-	1	$\mu A$
VGS(th)	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	1.65	2.5	V
RDS(on)	Drain-Source On-state Resistance <sup>3</sup>	$V_{GS} = 10V, I_D = 3A$	-	100	130	m $\Omega$
RDS(on)	Drain-Source On-state Resistance <sup>3</sup>	$V_{GS} = 4.5V, I_D = 1A$	-	135	190	
Ciss	Input Capacitance	$V_{GS} = 0V, V_{DS} = 50V, f = 1MHz$	-	200	-	pF
Coss	Output Capacitance		-	30	-	
Crss	Reverse Transfer Capacitance		-	2	-	
Qg	Total Gate Charge	$V_{DS} = 50V, V_{GS} = 10V, I_D = 3A$	-	4	-	nC
Qgs	Gate-Source Charge		-	0.6	-	
Qgd	Gate-Drain Charge		-	1.4	-	
td(on)	Turn-on Delay Time	$V_{DD} = 50V, V_{GS} = 10V, I_D = 3A, R_G = 3\Omega$	-	12.5	-	ns
t <sub>r</sub>	Turn-on Rise Time		-	19.5	-	
td(off)	Turn-off Delay Time		-	20	-	
t <sub>f</sub>	Turn-off Fall Time		-	29	-	
VSD	Body Diode Voltage <sup>3</sup>	$I_S = 3A, V_{GS} = 0V$	-	-	1.2	V
IS	Continuous Source Current		-	-	3.3	A

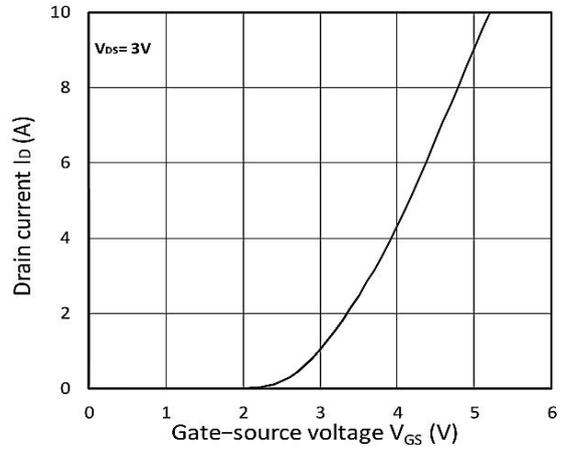
#### Note :

- 1、 The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3、 The power dissipation is limited by 150 $^{\circ}\text{C}$  junction temperature
- 4、 The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.

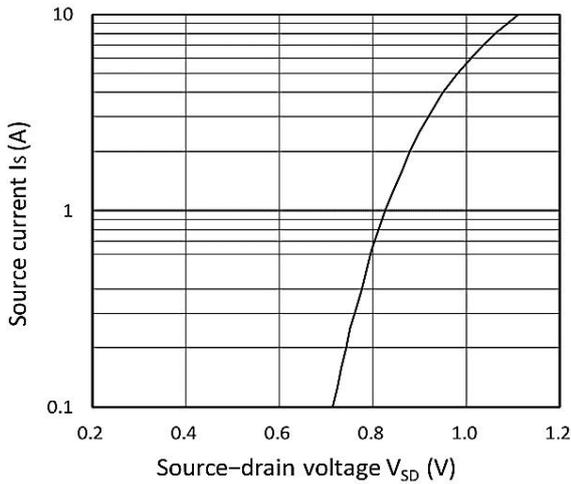
**Typical Characteristics**



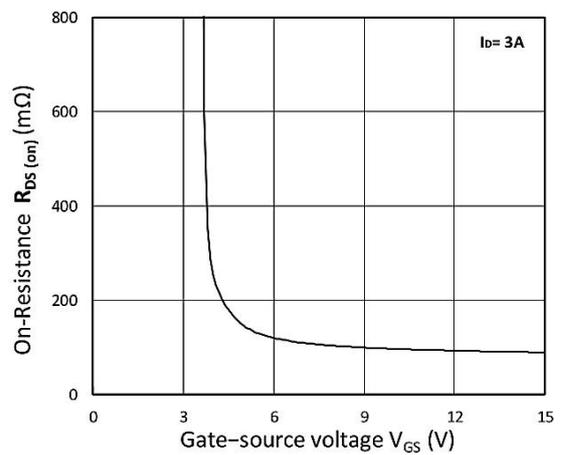
**Figure 1. Output Characteristics**



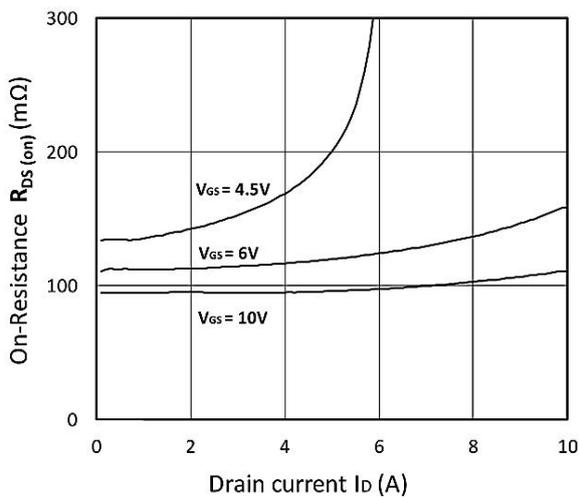
**Figure 2. Transfer Characteristics**



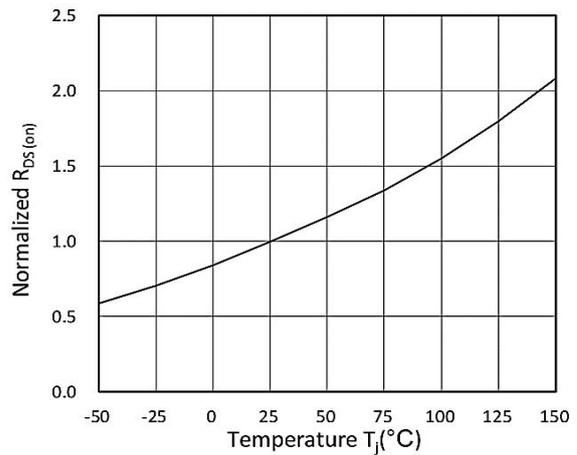
**Figure 3. Forward Characteristics of Reverse**



**Figure 4. RDS(ON) vs. VGS**

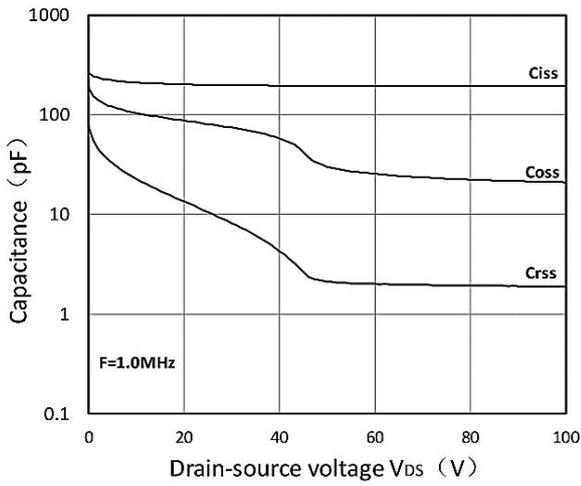


**Figure 5. RDS(ON) vs. ID**

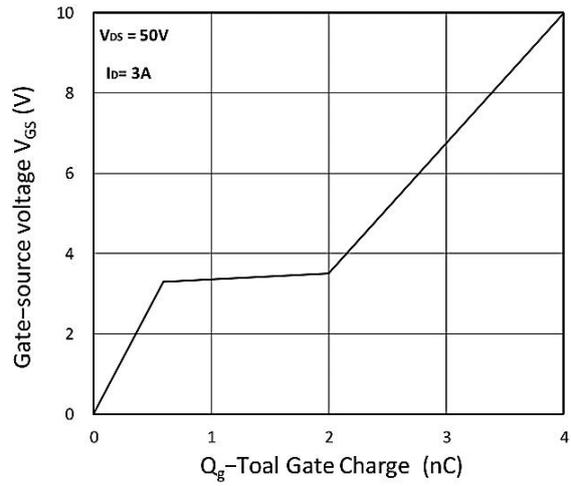


**Figure 6. Normalized R DS(on) vs. Temperature**

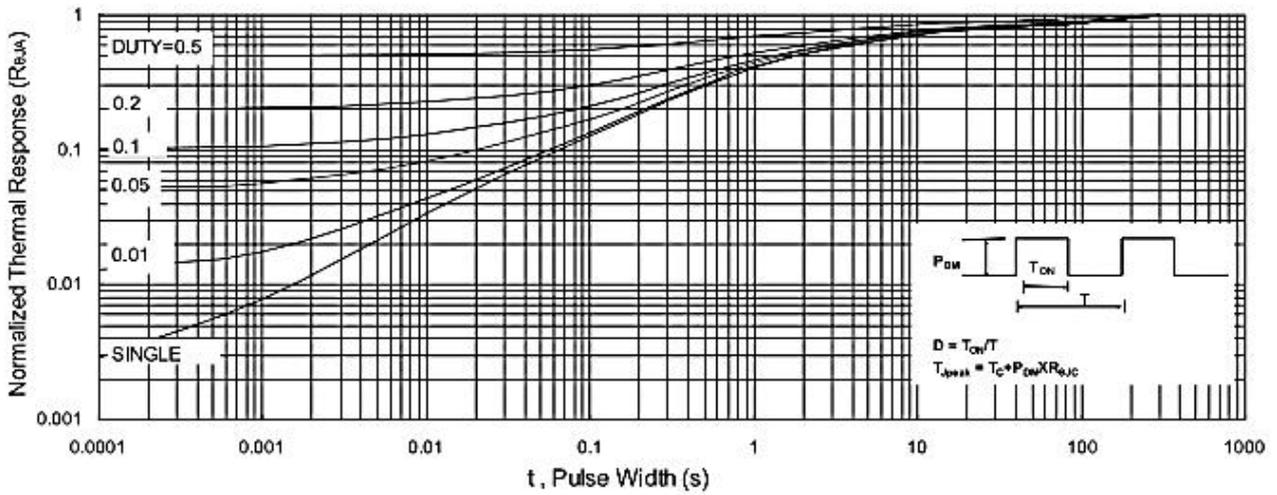
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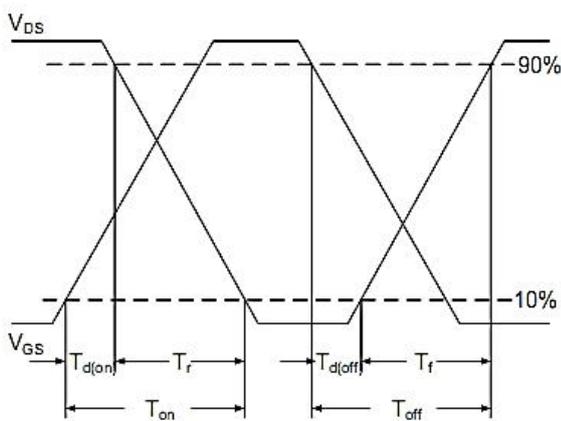
**Figure 7. Capacitance Characteristics**



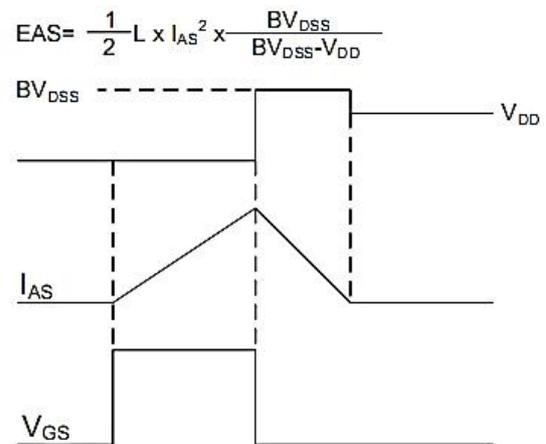
**Figure 8. Gate Charge Characteristics**



**Fig.9 Normalized Maximum Transient Thermal Impedance**

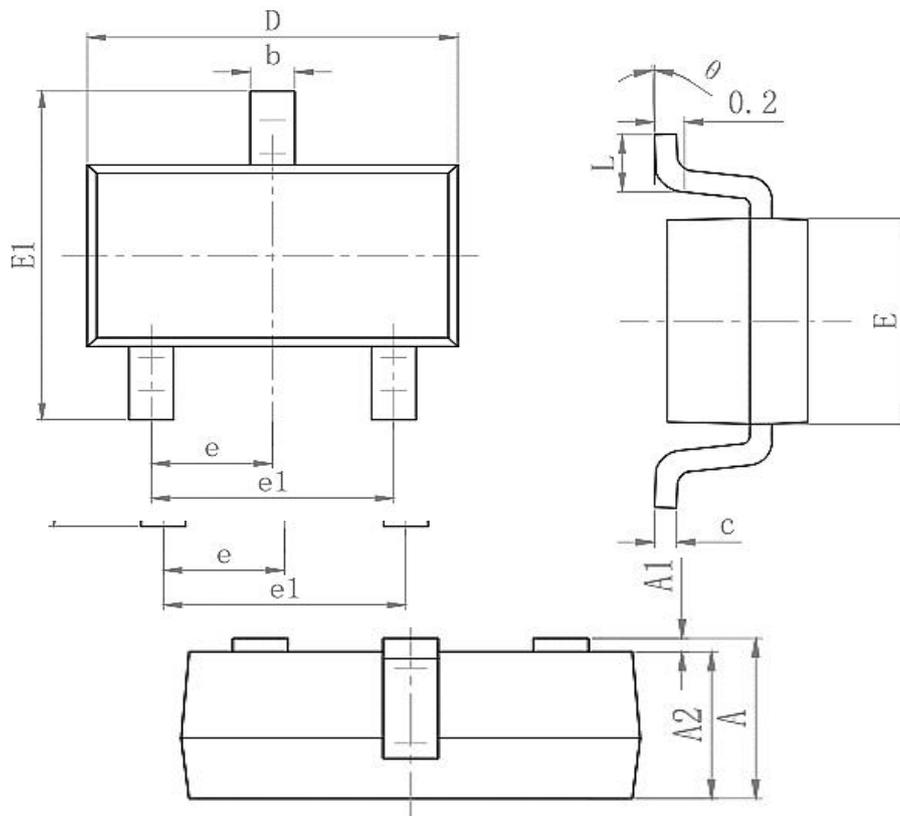


**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

### Package Mechanical Data-SOT23-XC-Single



Symbol	Dimensions In Millimeters	
	Min.	Max.
A	1.050	1.250
A1	0.000	0.100
A2	1.050	1.150
b	0.25	0.45
c	0.100	0.200
D	2.820	3.020
E	1.5	1.7
E1	2.650	2.950
e	0.950(BSC)	
e1	1.800	2.000
L	0.300	0.500
$\theta$	0°	8°

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